

Supplementary Material

Ag/MgO Nanoparticles via Gas Aggregation Nanocluster Source for Perovskite Solar Cells Engineering

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XPS of MgO on TiO₂

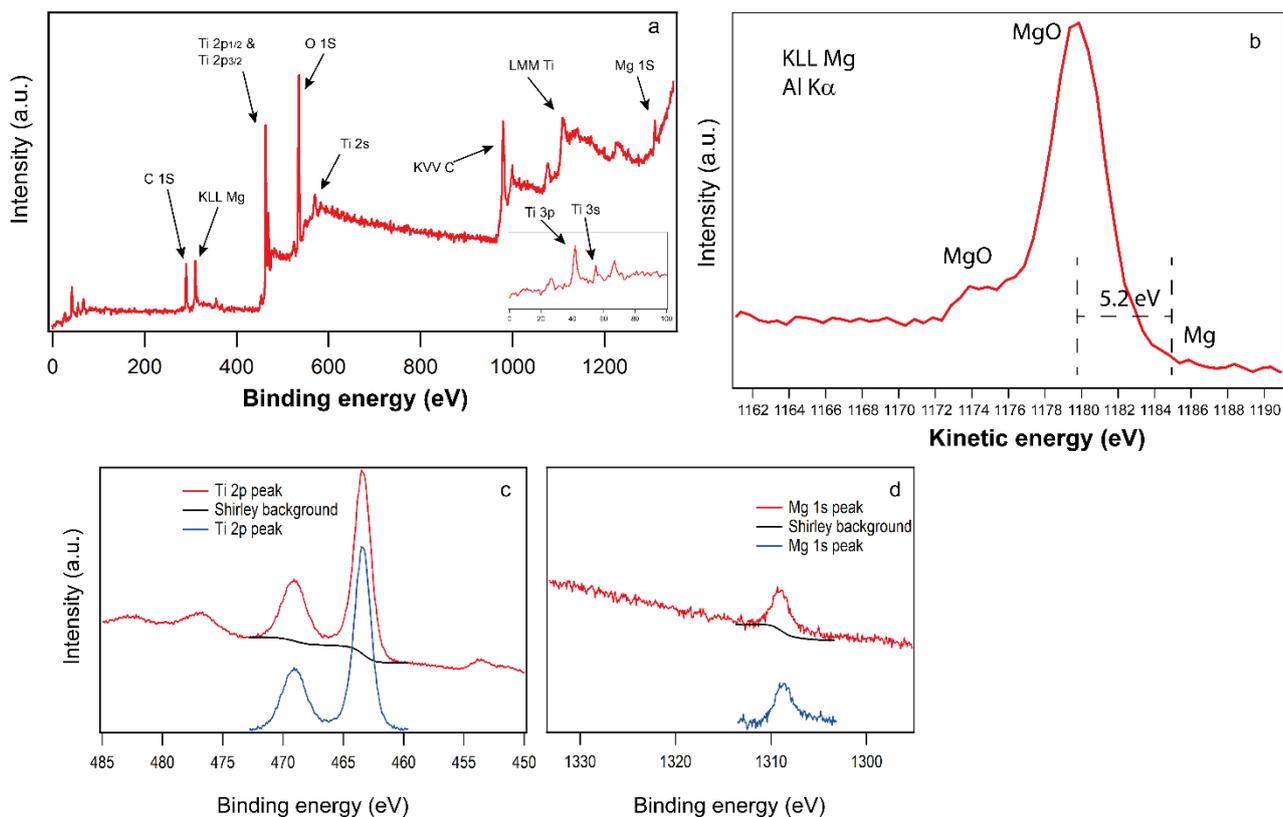


Figure S1: XPS (a) wide spectrum of the TiO₂ sample with MgO deposited on the surface, (b) Mg KLL, (c) Ti 2p core levels and (d) Mg 1s core levels with background subtractions.

AFM

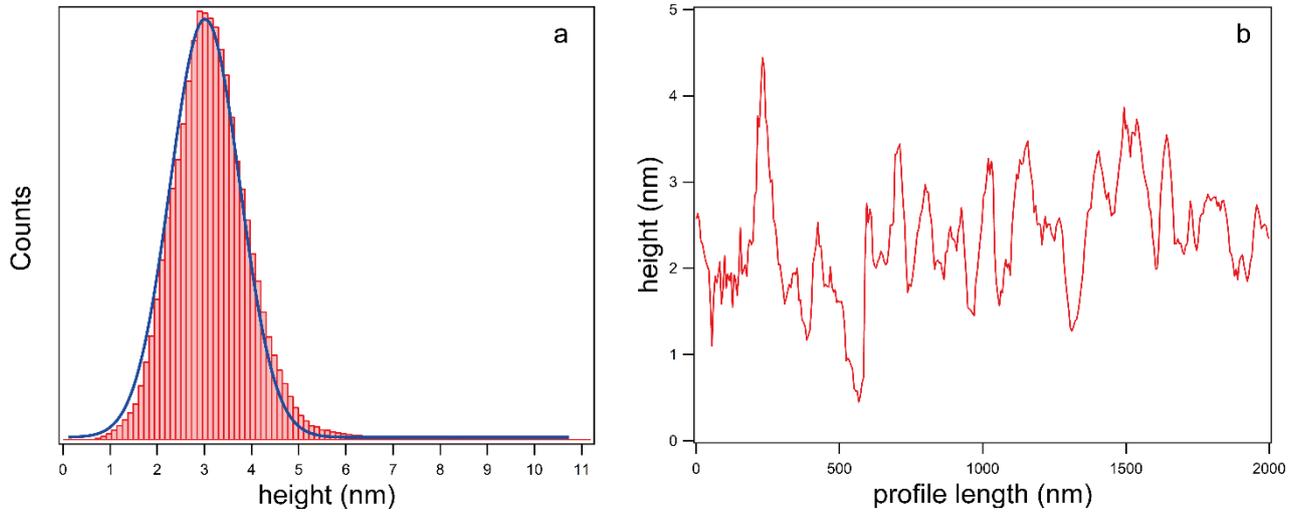
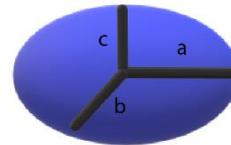


Figure S2: AFM (a) Height distribution of the substrate roughness (flat TiO₂) and (b) height of a profile line of 2 μm length.

Calculation of polarizability

The in-plane polarizability of a system made of isolated Ag oblate spheroids ($a = b > c$) embedded in a magnesia (MgO) matrix is calculated using Maxwell Garnett theory:

$$\alpha_{//}(\omega) \propto \frac{\epsilon_{Ag}(\omega) - \epsilon_{MgO}}{\epsilon_{MgO} + L_{//}(\epsilon_{Ag}(\omega) - \epsilon_{MgO})}$$



where $\epsilon_{Ag}(\omega)$ is the dielectric function of Silver, ϵ_{MgO} is the dielectric function of Magnesium Oxide, $L_{//}$ is the depolarisation factor of the in-plane direction. Different values of ϵ_{MgO} have been used according to what found in literature for thin layers of MgO.